Argonne NATIONAL LABORATORY

X-RAY SCIENCE DIVISION

J. LANG
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EXECUTIVE ASSISTANT J. KITCHING

ASSISTANT DIVISION DIRECTOR C. TRATTNER (6)
ESH COORDINATOR/QA REP. M. FRIES (4)
ADMINISTRATIVE ASSISTANT Y. BOUDREAU (6)
ADMINISTRATIVE ASSISTANT (HR) C. PENNELL (6)

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A. SCHULTZ (10) (5)

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J. LANG
INTERIM ASSOC. DIV. DIR.

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J. ILAVSKY
R. KLINGLER (5)
C. KMAK (6)
C. KURTZ
I. KUZMENKO
S. LEE
A. QUENTAL
B. REINHART
S. SEIFERT
X. WANG (3)
R. WINANS (5)(10)
X. ZUO

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X. ZHANG
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J. JIANG
C. LIU
L. SHOUDIS (6)
R. SPENCE
D. WALKO
J. WANG
M. ZAJAC (3)

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O. BORKIEWICZ
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T. LI (3)
L. RIBAUD
E. SARNELLO (3)
K. TADDEI
Y. WANG
J. WENG
K. WIADEREK
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Q. XU

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S. CORCORAN
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S. XU

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F. De CARLO
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A. DERIY
K. FEZZAA
A. KASTENGREN
S. KIM (3)
Y. LI
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V. NIKITIN
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GROUP LEADER
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A. DHAR (2)
T. EASTMOND (3)
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R. FERRY
R. HRUBIAK
F. HUMBLE
C. KENNEY-BENSON
C. PARK
D. POPOV
R. PRATOORI (2)
E. ROD
G. SHEN
J. SMITH
Y. XIAO

BL OPERATIONS
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ASSOCIATE DIV. DIR.

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E. ALP
E. ARAN
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J. H. KIM
R. KRAKORA
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T. TOELLNER
M. UPTON
J. ZHAO

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J. FREELAND
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M. KROGSTAD
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D. ROBINSON (10)
R. ROSENBERG (10)
P. RYAN
J. STREMPFER
R. WEBER (5)
H. ZHANG
J. ZIENTEK

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J. OKASINSKI
J. PARK
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B. LAI
GROUP LEADER
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C. BALSTEN (6)
Z. CAI
W. CHA
S. CHEN
J. DENG
M. FRITH
C. GUERRERO
R. HARDER
T. ISIK (3)
Y. JIANG
J. KLUG
P. LEE (3)
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X. LIU (3)
A. LUKTUKE (3)
G. LUO
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N. RAHMAN (3)
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S. WIEGHOLD

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R. GAGNON (6)
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M. WANG (3)
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GROUP LEADER
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D. JENSEN (6)
Z. JIANG
L. SHOUDIS (6)
J. STRZALKA
A. TRIPATHI (6)
Q. ZHANG
R. ZIEGLER

EBERLIGHT
K. MICHALSKA
GROUP LEADER

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A. SANDY
ASSOCIATE DIV. DIR.

BEAMLINE INSTRUMENTATION
M. FISHER
GROUP LEADER
(S. BEAN)
E. BENDA
(T. BENDER)
A. BERNHARD
(D. CAPATINA)
B. DAVIS
(A. KHAN)
(J. KNOPP)
G. NAVROTSKI
(C. PREISSNER)
L. SHOUDIS (6)
J. TAN
(K. WAKEFIELD)

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GROUP LEADER
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P. JEMIAN
J. KIRCHMAN
(K. LANG)
N. MARKS
B. MONK
T. MOONEY
K. PETERSON
F. RODOLAKIS
T. WALSH
M. WYMAN

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GROUP LEADER
T. BICER (4)
Y. BOUDREAU (6)
A. CHANDRASEKHAR (3)
D. CHING
Z. DI (4)
D. GURSOY
J. HORWATH (3)
H. SHARMA
B. TOBY
A. TRIPATHI (6)
M. VAN VEENENDAAL
B. VON DREELE (5)

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GROUP LEADER
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Y. BOUDREAU (6)
A. BREWE (2)
L. GADES
S. GNANASEKARAN (2)
T. GURUSWAMY
M. HAMMER
U. PATEL
C. PIATAK
O. QUARANTA
H. SHI
S. STREMPFER (2)
P. TRIAMKITSAWAT (2)
J. WEIZEORICK

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(J. ANTON)
(S. KEARNEY)
S. MASHRAFI
L. SHOUDIS (6)
D. SHU

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L. ASSOUFID
GROUP LEADER
P. LIU (3)
A. MACRANDER (10)
C. PENNELL (6)
J. QIAN
L. REBUFFI
R. REININGER (10)
X. SHI
Y. SHVYDKO
M. WOJCIK
R. ZHANG (3)

CRYSTAL OPTICS FABRICATION AND CHARACTERIZATION
X. HUANG
B. STONE
W. BURNS

THIN FILM AND MIRROR OPTICS
R. CONLEY
B. SHI

SCIENTIFIC SOFTWARE ENGINEERING AND DATA MANAGEMENT
N. SCHWARZ
GROUP LEADER
Y. BOUDREAU (6)
M. CHU
B. FROSIK
A. GLOWACKI
J. HAMMONDS
S. HENKE
P. MYINT
H. PARRAGA
M. PRINCE
H. RUTH
(S. VESELI)

BEAMLINE DEVELOPMENT
D. HAEFFNER
ASSOCIATE DIV. DIR.
(M. HIGHLAND)

EMPLOYEES MATRIXED ≧ 50% TO APS UPGRADE ARE LISTED IN HOME DIVISION WITH NAME IN PARENTHESES

KEY:

* REPORT TO THE LABORATORY DIRECTOR
(1) INTERIM
(2) STUDENT
(3) POSTDOCTORAL
(4) OTHER DIVISION
(5) ARGONNE ASSOCIATE
(6) MULTIPLE ASSIGNMENTS
(7) CONTRACT PERSONNEL
(8) VISITING FACULTY/SCIENTIST
(9) LEAVE OF ABSENCE
(10) EMERITUS

EFFECTIVE:October 1, 2023

October 1, 2023

APPROVED: J. Lang
Director

DATE